

Title of Change:	ON Semiconductor is expanding assembly capacity via qualifying external package/assembly subcontractor. Applicable to the family of products (and related OPNs) NCP3230, NCP3231A, NCP3231, NCP3232N, NCP3233, NCP3235 and NCP5339. Ref: IPCN 22203X		
Proposed first ship date:	19 October 2018 or earlier upon customer approval		
Contact information:	Contact your local ON Semiconductor Sales Office or Joe Chong <joe.chong@onsemi.com></joe.chong@onsemi.com>		
Samples:	Contact your local ON Semiconductor Sales Office or < <u>PCN.samples@onsemi.com</u> > Sample requests are to be submitted no later than 30 days from the date of first notification, Initial PCN or Final PCN, for this change.		
Additional Reliability Data:	Contact your local ON Semiconductor Sales Office or Paul Syndergaard <paul.syndergaard@onsemi.com></paul.syndergaard@onsemi.com>		
Type of notification:	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. ON Semiconductor will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact < <u>PCN.Support@onsemi.com></u>		
Change Part Identification:	Parts can be identified through date code marking following ON Semiconductor standards. Contact your local ON Semiconductor Sales Office for the specific date code information.		
Change Category:	Wafer Fab Change Assembly Change Test Change Other		
	er Product specific change ange ON Semiconductor Sites: None the subject products assembly capacity via addition neet specifications, or any other aspect of the product	 Datasheet/Product Doc change Shipping/Packaging/Marking Other: External Foundry/Subcon Sites: Advanced Semiconductor Engineering (ASE), Penang, Malaysia 	
Item to be changed: Addition of Product Assembly Site	ON Semiconductor, Seremban, Malaysia (Internal Assembly Facility)	After Change Description After the change, Assembly will be done in two locations: 1. ON Semiconductor, Seremban, Malaysia 2. Advanced Semiconductor Engineering (ASE), Penang, Malaysia (subcontractor)	



Reliability Data Summary:

QV DEVICE NAME NCP3231AMNTXG NCP3235MNTXG NCP5339MNTXTG PACKAGE QFN 40 6*6

Test	Specification	Condition	Interval	Results
HTOL	JESD22-A108	Ta=125°C, 100 % max rated Vcc	1008 hrs	0/252
TC	JESD22-A104	Ta= - 65°C to +150°C	500 сус	0/240
HAST	JESD22-A110	130°C, 85% RH, 18.8psig, bias	96 hrs	0/240
PC	J-STD-020 JESD-A113	MSL 3 @ 260 °C	Pre HAST/TC	0/ 1473
RSH	JESD22- B106	Ta = 265C, 10 sec		0/270
SAT	JSTD035	Scanning Acoustical Tomography	Delam check Pre/post PC	0/ 225
ED	ON Datasheet	Electrical Distribution	Compared to control lot	>1.67

Electrical Characteristic Summary:

Electrical characteristics are not impacted.

List of Affected Parts:

Part Number	Qualification Vehicle
NCP3230MNTXG	
NCP3231MNTXG	NCP3231AMNTXG NCP3235MNTXG NCP5339MNTXG
NCP3231AMNTXG	
NCP3232NMNTXG	
NCP3233MNTXG	
NCP5339MNTXG	
NCP3235MNTXG	



Appendix A: Changed Products

Product	Customer Part Number	Qualification Vehicle
NCP3230MNTXG		NCP3231A, NCP3235 AND NCP5339
NCP3231AMNTXG		NCP3231A, NCP3235 AND NCP5339
NCP3231MNTXG		NCP3231A, NCP3235 AND NCP5339
NCP3232NMNTXG		NCP3231A, NCP3235 AND NCP5339
NCP3233MNTXG		NCP3231A, NCP3235 AND NCP5339
NCP3235MNTXG		NCP3231A, NCP3235 AND NCP5339
NCP5339MNTXG		NCP3231A, NCP3235 AND NCP5339